

LMN3660EX5F 30V N-Channel Enhancement Mode MOSFET

Features

- Low Gate Charge
- ESD Protected
- SOT-523 package design

Product Description

LMN3660E, N-Channel enhancement mode MOSFET, uses Advanced Trench Technology to provide excellent R_{DS(ON)}, low gate charge.

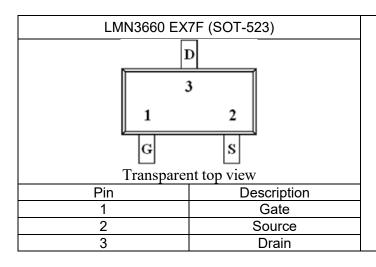
These devices are particularly suited for low

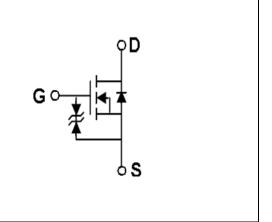
voltage power management, such as smart phone and notebook computer, and low in-line power loss are needed in commercial industrial surface mount applications.

Applications

- Power Management in Note book
- Portable Equipment
- Load Switch

Pin Configuration





LMN3660EX7F



Ordering Information

Ordering Information						
Part Number P/N		PKG code	Pb Free code	Package	Quantity	
LMN3660EX7F	LMN3660E	X7	F	SOT-523	3000 PCS	

Marking Information

Marking Information				
Part Marking	Part Number	LFC code		
0WM	0	WM		

Absolute Maximum Ratings

(T_C=25°C Unless otherwise noted)

Symbol	Parameter	Typical	Unit
V_{DSS}	Drain-Source Voltage	30	V
V_{GSS}	Gate-Source Voltage	±12	V
I _D	Continuous Drain Current T _A =25°C¹	0.51	А
I _{DM}	Pulsed Drain Current ²	2	А
P_D	Power Dissipation	0.3	W
TJ	Operating Junction Temperature	-55 to +150	°C
T _{STG}	Storage Temperature Range	-55 to +150	°C
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient ¹	450	°C/W

Notes:

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^{1.} Surface mounted on a 1 inch2 FR-4 board with 2oz copper.

^{2.} Pulse width limited by maximum junction temperature, Pulse Width≤300µs, Duty Cycle≤1%.



Electrical Characteristics

(T_C=25°C Unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
		Static					
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V_{GS} =0 V , I_D =250 u A	30			V	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250Ua$	0.5		1.5	V	
I _{GSS}	Gate Leakage Current	V_{DS} =0V, V_{GS} =±12V			10	uA	
I _{DSS}	Zero Gate Voltage Drain Current	V_{DS} =24V, V_{GS} =0V			100	nA	
	Drain-Source On-Resistance	V_{GS} =10V, I_D =0.5A		355	600		
$R_{DS(on)}$		V_{GS} =4.5 V , I_{D} =0.4 A		435	650	mΩ	
		V_{GS} =2.5 V , I_{D} =0.3 A		665	1200		
g FS	Forward Transconductance	V_{DS} =10V, I_{D} =0.5A		1.1		S	
V_{SD}	Diode Forward Voltage	$I_S=0.5A$, $V_{GS}=0V$			1.35	V	
		Dynamic					
Q_g	Total Gate Charge	\/ -45\/ \/ -40\/		1.5		nC	
Q _{gs}	Gate-Source Charge	V_{DS} =15V, V_{GS} =10V, I_{D} =0.5A		0.2			
Q_{gd}	Gate-Drain Charge	ID-0.5A		0.2			
C _{iss}	Input Capacitance	\/ 45\/\\ 0\/		39			
Coss	Output Capacitance	V_{DS} =15V, V_{GS} =0V,		9		pF	
C _{rss}	Reverse Transfer Capacitance	f=1MHz		6		•	
t _{d(on)}	Trum On Times	V _{DD} =15V, I _D =0.5A,		5.3		ns	
t _r	Turn-On Time			16			
t _{d(off)}	T O# Time -	V_{GS} =10V, R_{G} =2.5 Ω		20			
t _f	Turn-Off Time	·		18			



Typical Performance Characteristics

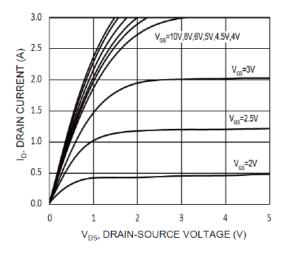
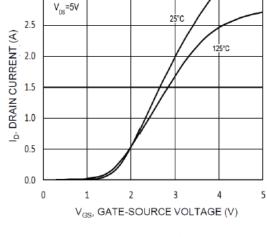
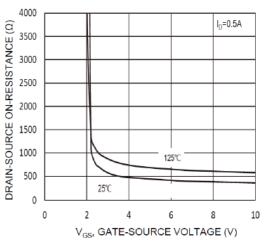


Fig. 1 Typical Output Characteristics



3.0

Fig. 2 Typical Transfer Characteristics



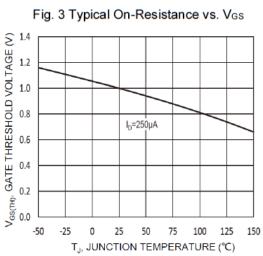


Fig. 5 Normalized Threshold Voltage

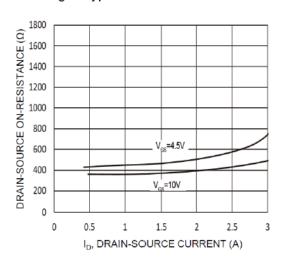


Fig. 4 Typical On-Resistance vs. ID

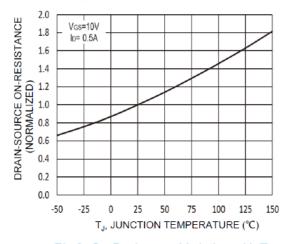
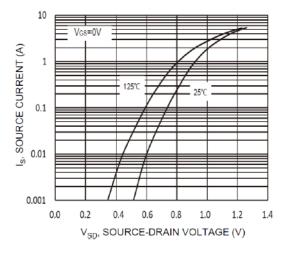


Fig 6. On-Resistance Variation with TJ



Typical Performance Characteristics(continue)



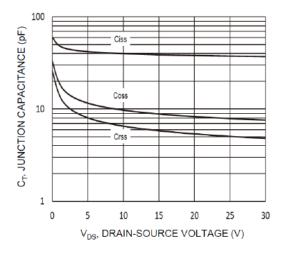


Fig. 7 Diode Forward Voltage vs. Current

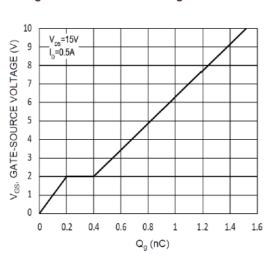


Fig. 8 Typical Capacitance

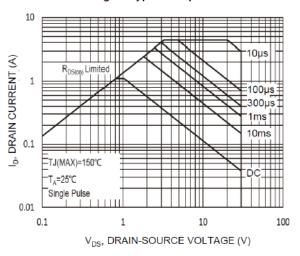


Fig. 9 Gate Charge



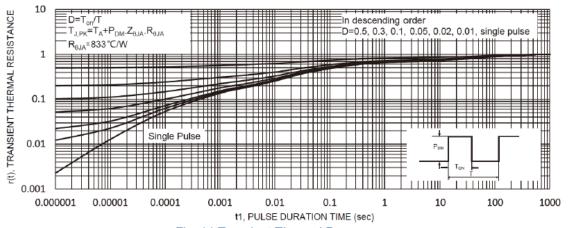
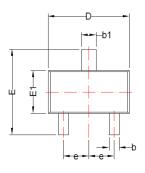


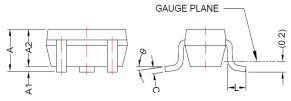
Fig. 11 Transient Thermal Response



Package Dimension:

SOT-523





	Dimensions				
Cumbal	Millimeters		Inches		
Symbol	Min	Max	Min	Max	
Α	0.60	0.95	0.024	0.037	
A1	0.00	0.10	0.000	0.004	
A2	0.60	0.85	0.024	0.033	
b	0.15	0.30	0.006	0.012	
b1	0.25	0.40	0.010	0.016	
С	0.08	0.25	0.003	0.010	
D	1.40	1.80	0.055	0.071	
E	1.40	1.80	0.055	0.071	
E1	0.70	0.90	0.028	0.035	
е	0.50 BSC		0.020	BSC	
L	0.26	0.45	0.010	0.018	
θ	0°	8°	0°	8°	



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